



# Novel laser-engineered surfaces for electron cloud mitigation

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University of Dundee

# FUNCTIONAL MATERIALS *for* OPTICAL & PARTICLE BEAMS

## Manufacturing with Light

### ***Collaborators:***

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Warrington, WA4 4AD Cheshire, UK*

- ① Fabrication & processing of novel functional materials
- ② Laser functionalisation of traditional materials
- ③ Complex photonics

**IMPACT & POTENTIAL APPLICATIONS:** storage of information, sensing, circuitry & security, energy sector, particle accelerators, healthcare & creative industries fundamental optical studies, beam shaping, laser technology.







*Virtual  
Engineering  
Centre*

*Innovation  
Centre*

*Cockcroft  
Institute*

*Vanguard  
House*

*Hartree Centre*

*Innovations  
Technology Access  
Centre (ITAC)*

*HPC*

*VELA/CLARA  
Facilities*

*ALICE/EMMA  
Facilities*

*SuperStem*

*Engineering  
Technology Centre*

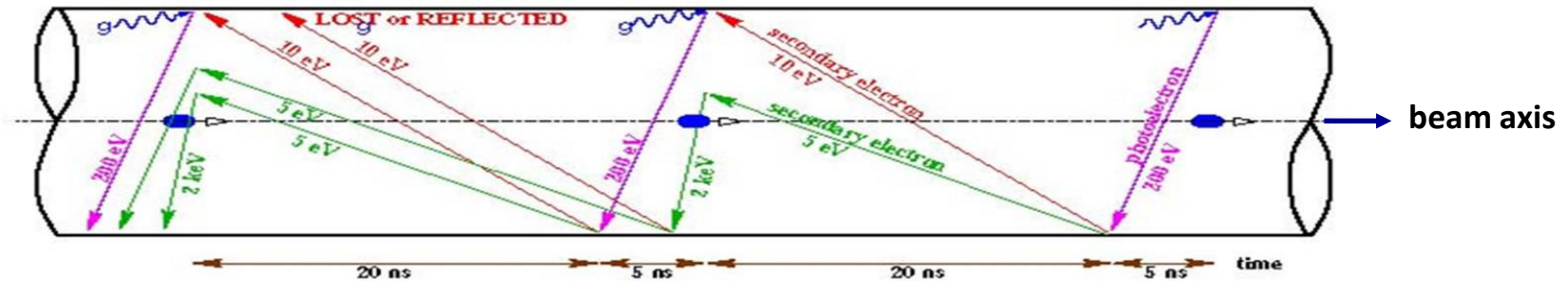


# STFC Daresbury Laboratory

- ASTeC Vacuum Science Group
  - SEY measurement and surface analysis facility
  - Electron stimulated desorption
  - RF impedance measurement facility
  - Expertise in e-cloud mitigation in particle accelerators
  - Design of particle accelerator vacuum systems
- STFC grant for Proof of Concept work (2014)



# Basic aim of our studies – reduction in SEY



1. Mitigation of beam-induced electron multipacting and electron cloud build-up in a particle accelerator beam chamber due to photo- and secondary electron emission
2. Reduction in beam instability, beam losses and emittance growth, & reduction in beam lifetime or heat loads on cryogenic vacuum chambers
3. Multipactor mitigation in RF wave guides and space-related high-power RF hardware
4. Reducing the PEY and SEY in other instruments and devices, where necessary

**Standard Objective** Reduce The Secondary Electron Yield (e.g.  $\delta_{\max} < 1.3$  for CERN SPS):

- by Changing surface Chemistry (deposition of lower SEY material)
- by Engineering the surface roughness
- by a Mixture of the above

# Existing Mitigation Methods

## ***By active means:***

- Weak solenoid field (10 - 20G) along the vacuum chamber
- Biased clearing electrodes
- Charged particle beam train parameters
  - Bunch charge and sizes
  - Distance between bunches

## **Advantages:**

- Solenoids can be installed on existing facilities (if there is space for them)
- Beam parameters have some flexibility

## **Disadvantages:**

- Requires:
  - controllers
  - power supplies
  - cables
  - vacuum-compatible feedthroughs

**i.e. should be avoided if possible**

## ***By passive means:***

- Low SEY material
- Low SEY coating
- Grooved surfaces
- Special shapes of vacuum chambers
  - an antechamber allows reducing PEY

## **Advantages:**

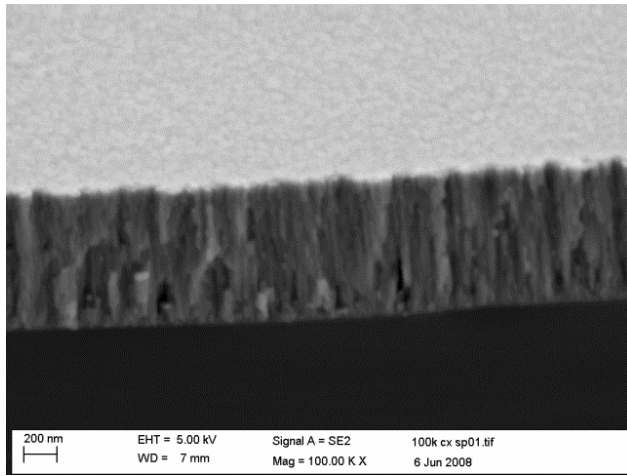
- No Controllers,  
no power supplies,  
no cables

## **Disadvantages:**

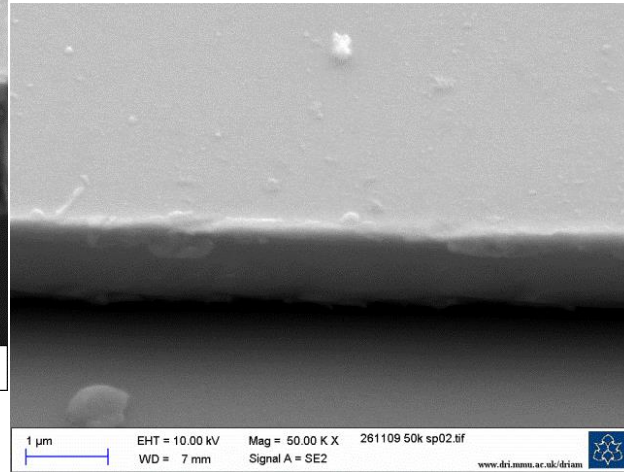
- in-vacuum deposition
- difficult to apply on existing facilities
- inconvenient & expensive chamber modifications

# Existing Mitigation Methods

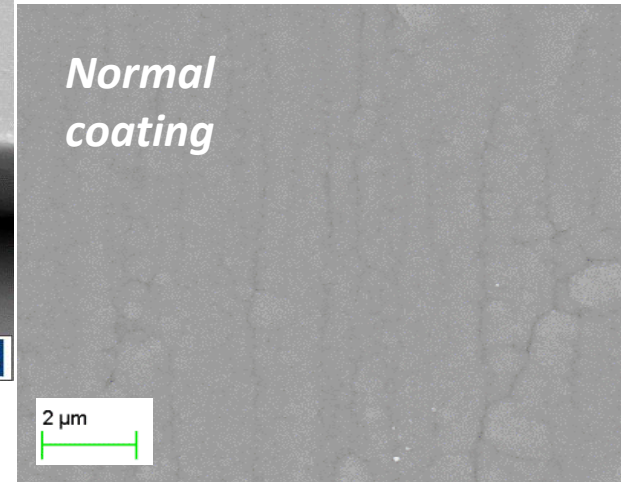
## 1. Coating with Low SEY Material



**Ti-Zr-V-Hf**



**Ti-Zr-Hf-V-N**

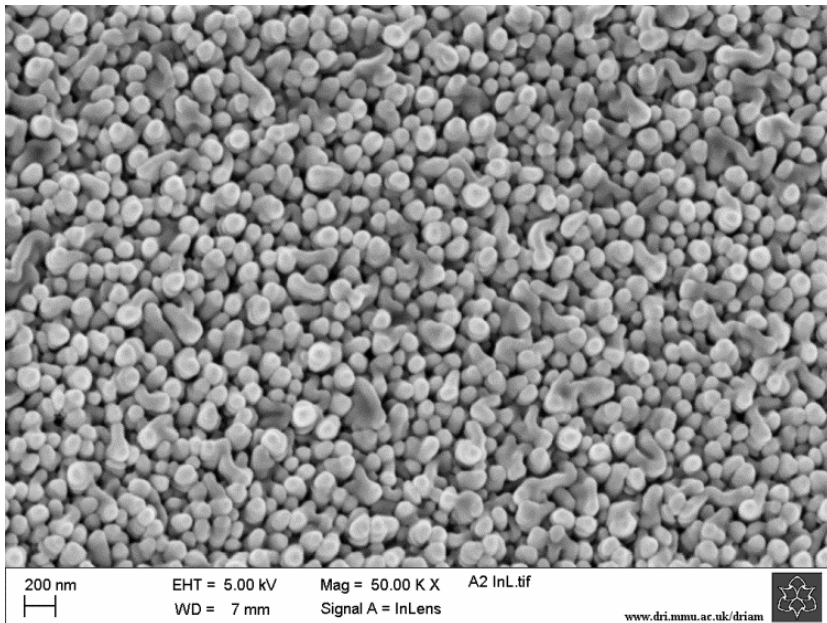


**a-C at CERN**

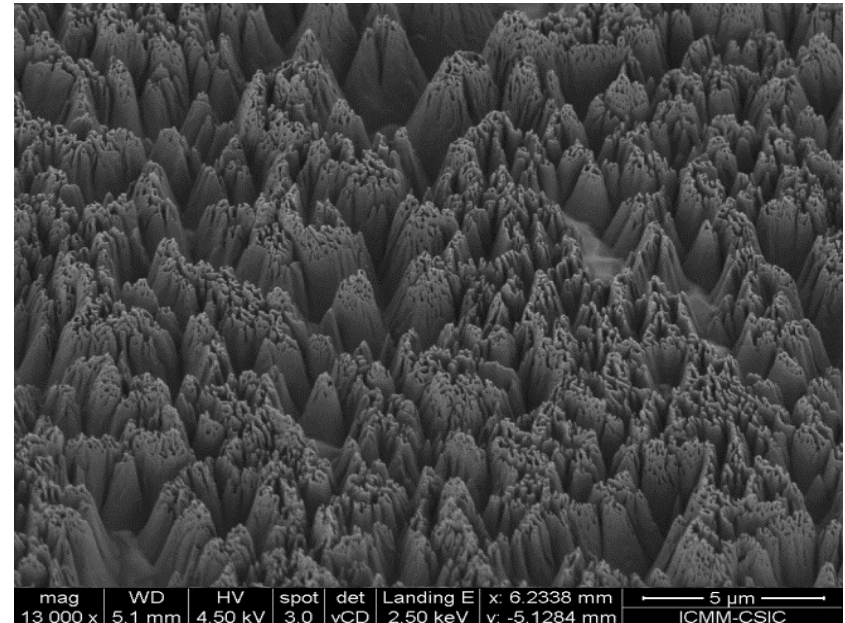


# Existing Mitigation Methods

## 2. Coating with a low SEY material with sub-micron size structure



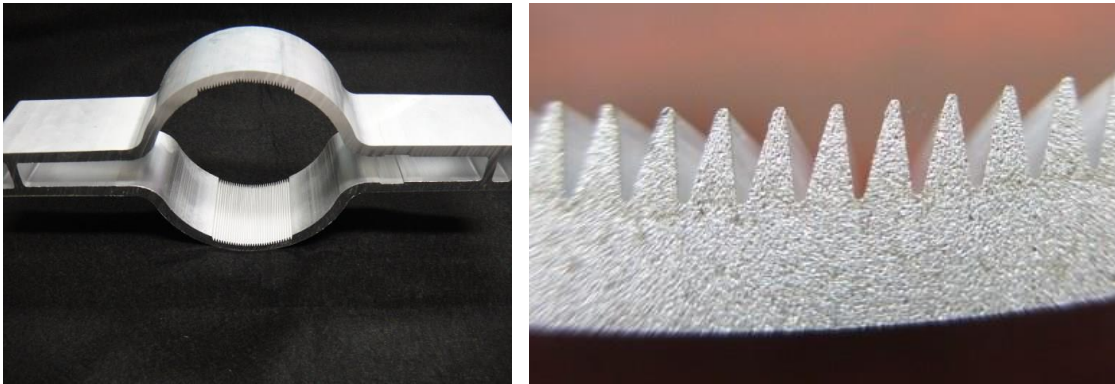
Ti-Zr-V black



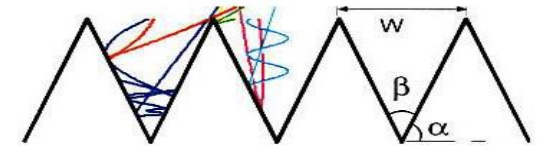
Ag plating, ion etched with Mo Mask  
I. Montero et. al, Proc. e-Cloud12

# Existing Mitigation Methods

## 3. Modifying the surface geometry making mechanical grooves

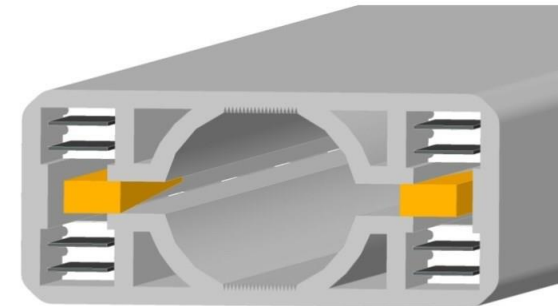


KEKB vacuum chamber (by courtesy of Y. Suetsugu)



By A. Krasnov and  
by L Wang et.al

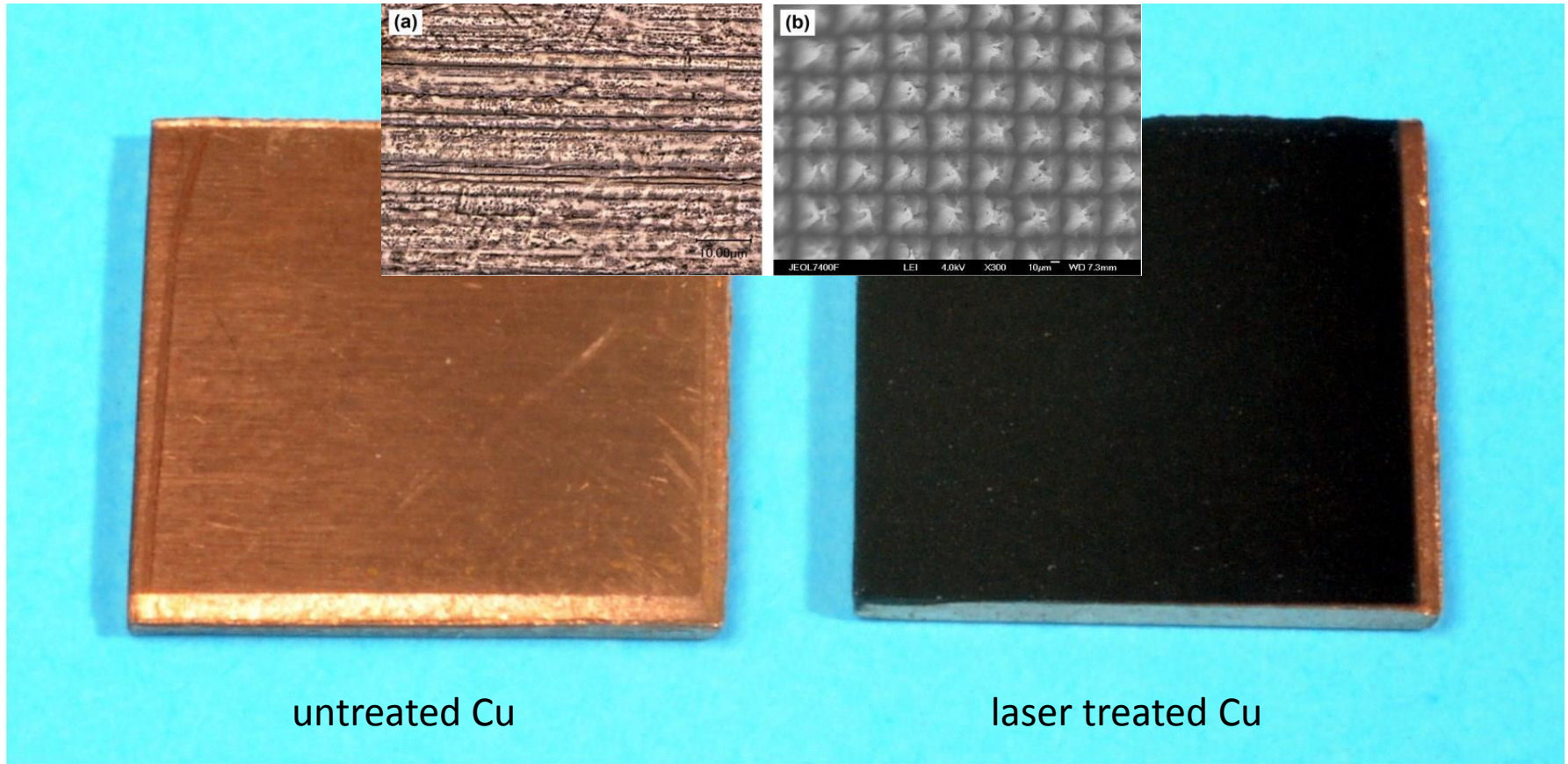
## 4. Modifying the vacuum chamber geometry making an antechamber



ILC wiggler vacuum chamber

# Introducing new technology

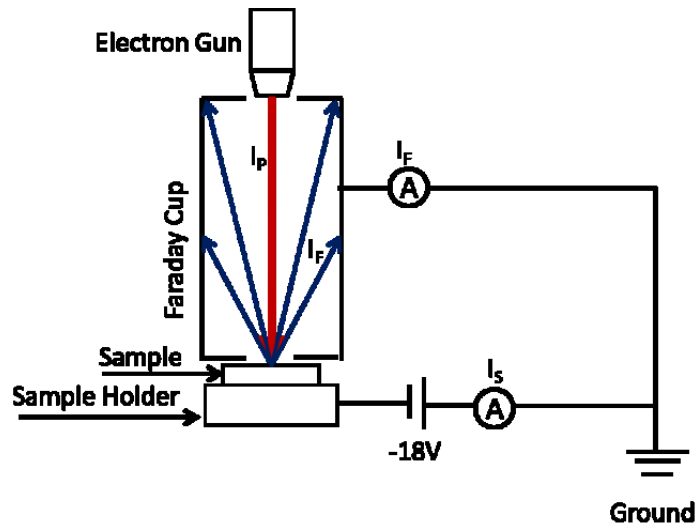
- Laser treatment of metal surfaces in air or noble gas atmosphere



- beam is raster-scanned in both horizontal and vertical directions
- with average laser energy fluence just above ablation threshold of the metal
- We call these **“Laser-engineered surface structures” (LESS)**



# SEY Measurements at STFC Daresbury Laboratory



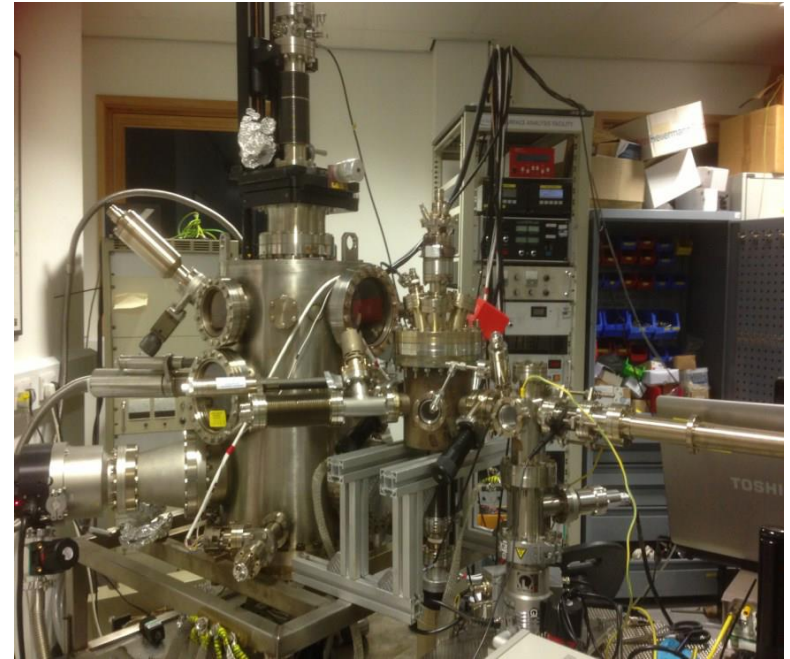
Define the **secondary electron yield**,  
**SEY** or  $\delta$ , in the usual way

$$\delta = \frac{I_F}{I_P} = \frac{I_F}{I_F + I_S}$$

$I_P$  is the primary beam current

$I_F$  is the secondary electron current, including elastic and inelastic processes, measured on the Faraday cup

$I_S$  is the current on the sample

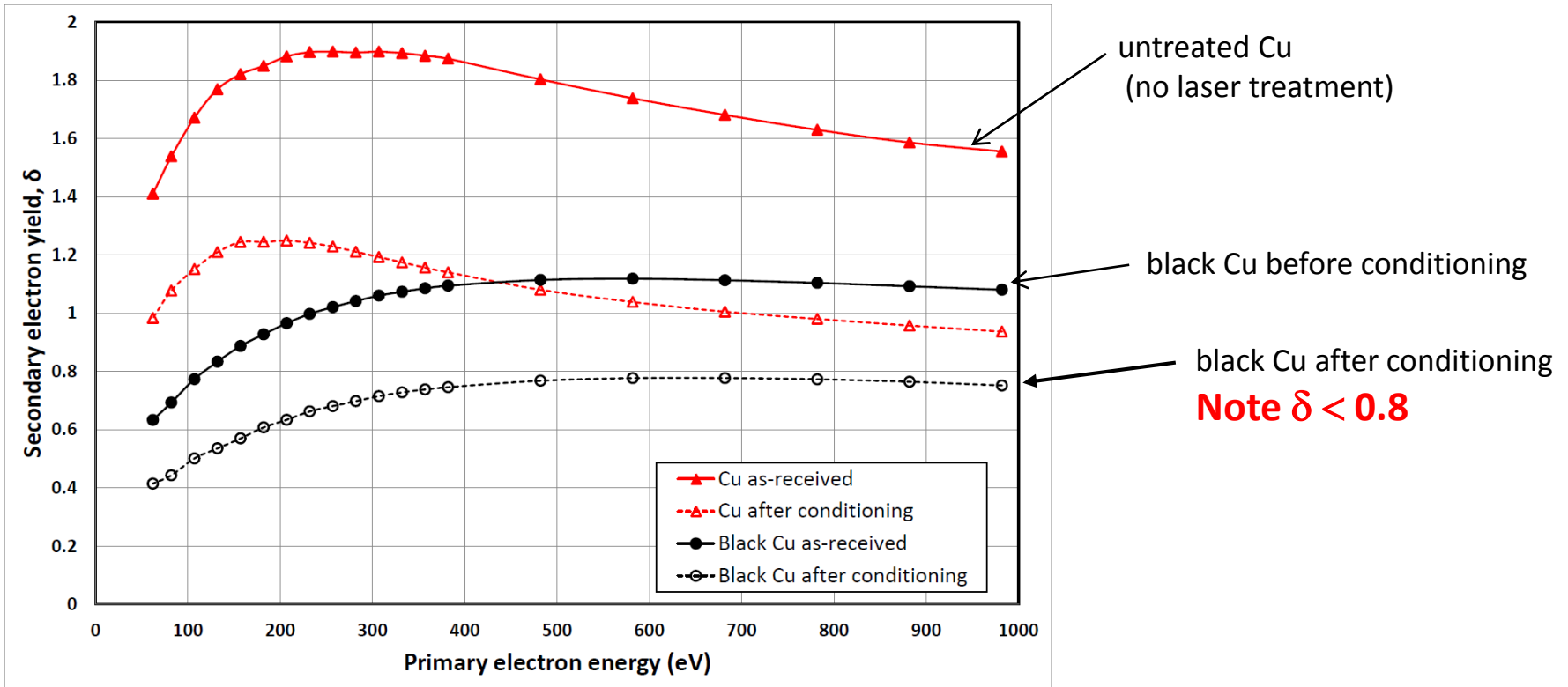


Analysis chamber with:

- XPS
- Flood e-gun (0.5 – 2.0 keV)
- Sample heater
- Argon ion beam

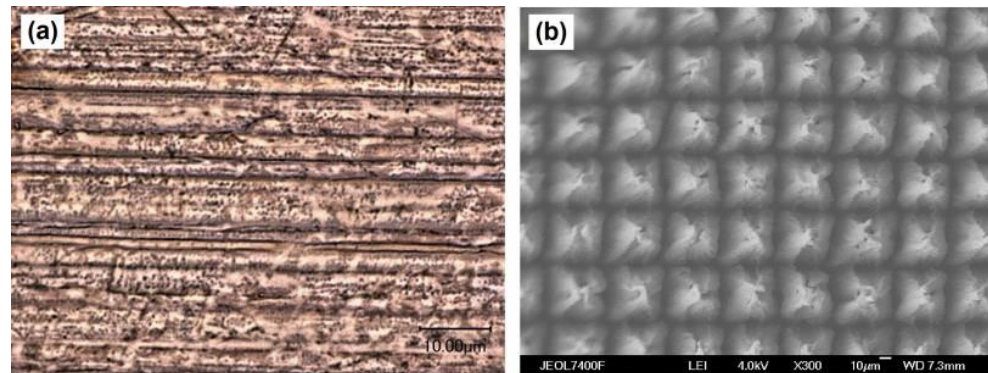


# RESULTS: SEY of Cu as a function of incident electron energy



Original Data  
June 2014

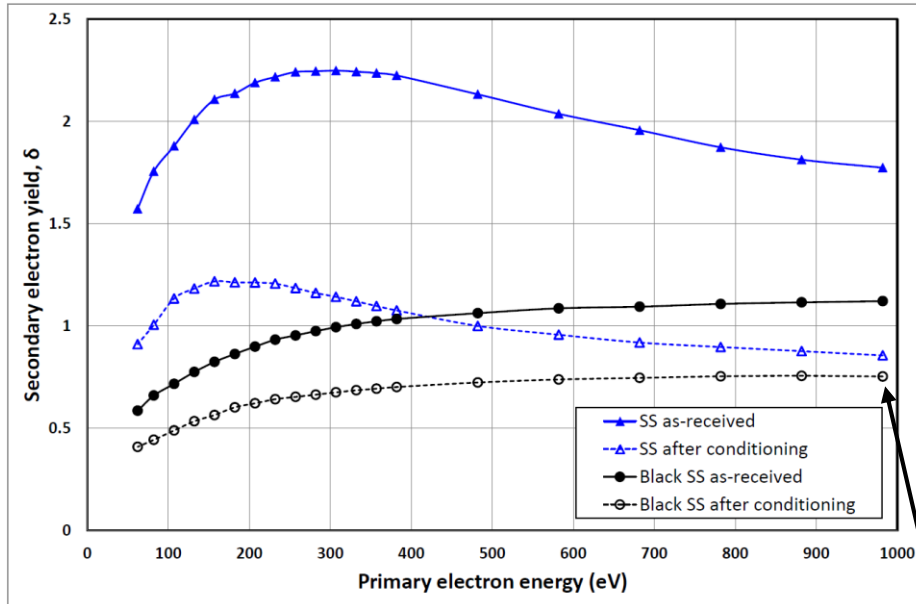
We have **complete control** over the highly regular surface topography



High-resolution SEM images of the Cu samples:  
(a) untreated and (b) laser treated

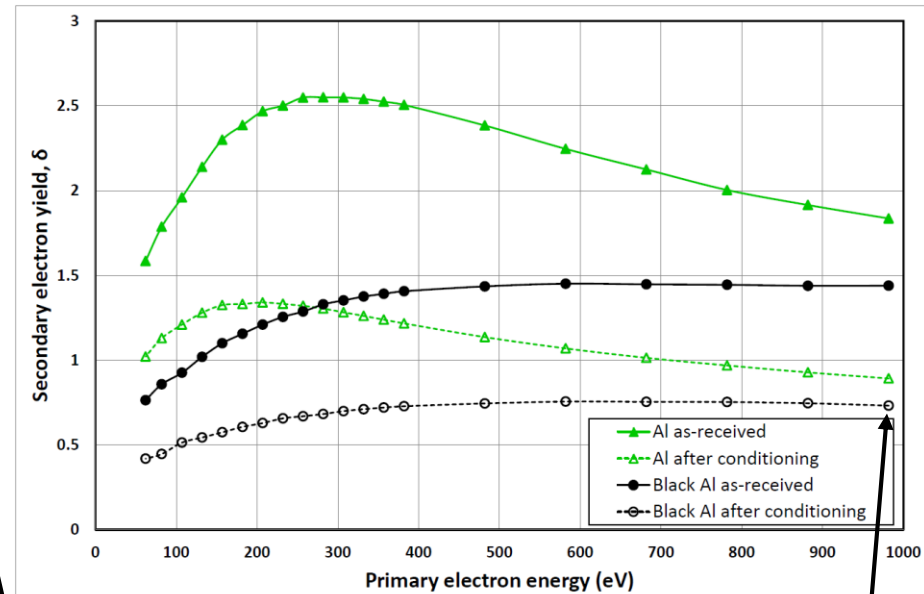
# RESULTS: SEY of SS & Al as a function of incident electron energy

stainless steel



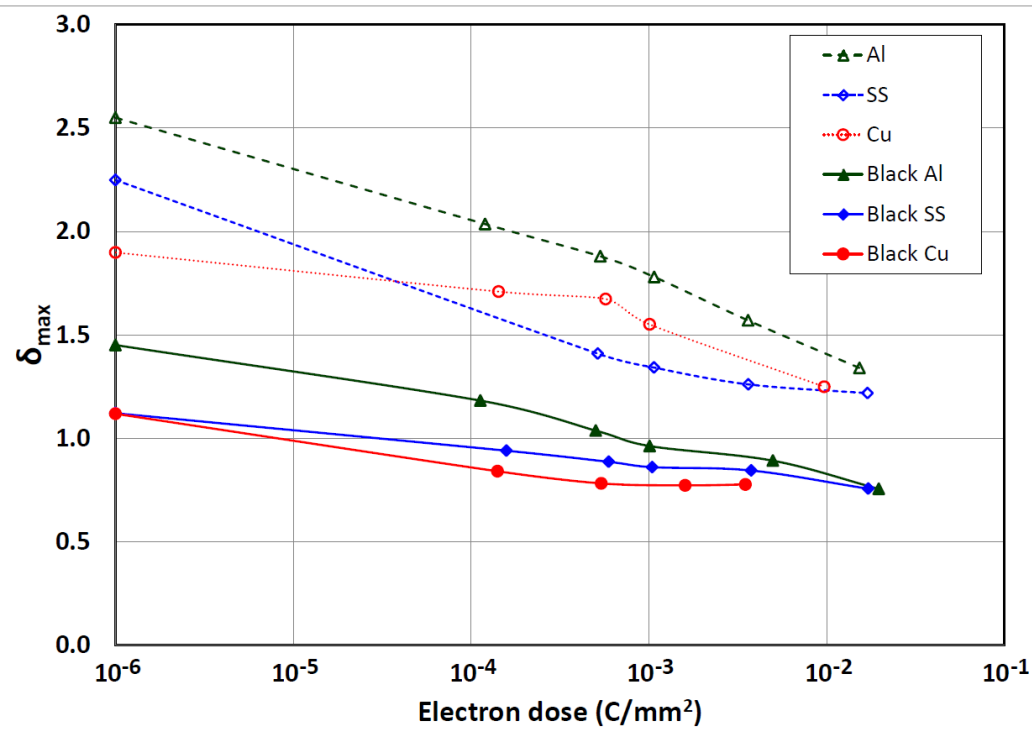
Note  $\delta < 0.7$

aluminium



Note  $\delta < 0.7$

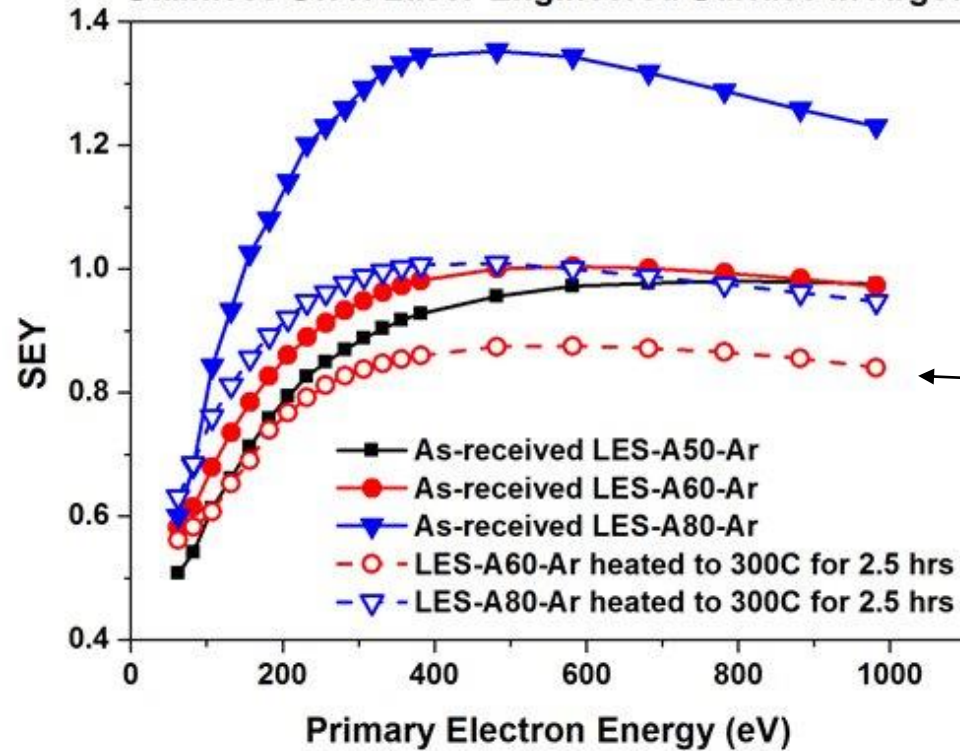
# $\delta_{\max}$ as a function of electron dose for Al, 306L SS and Cu



Sample	Initial		After conditioning to $Q_{\max}$		
	$\delta_{\max}$	$E_{\max}$ (eV)	$\delta_{\max}$	$E_{\max}$ (eV)	$Q_{\max}$ (C·mm <sup>-2</sup> )
Black Cu	1.12	600	0.78	600	$3.5 \times 10^{-3}$
Black SS	1.12	900	0.76	900	$1.7 \times 10^{-2}$
Black Al	1.45	900	0.76	600	$2.0 \times 10^{-2}$
Cu	1.90	300	1.25	200	$1.0 \times 10^{-2}$
SS	2.25	300	1.22	200	$1.7 \times 10^{-2}$
Al	2.55	300	1.34	200	$1.5 \times 10^{-2}$

Reduction of  $\delta_{\max}$  after conditioning is attributed to change in surface chemistry due to electron-beam induced transformation of CuO to sub-stoichiometric oxide, and build-up of a thin graphite C-C bonding layer on the surface. This is verified by the XPS results.

Stainless Steel Laser-Engineered Surface in Argon



Stainless steel data

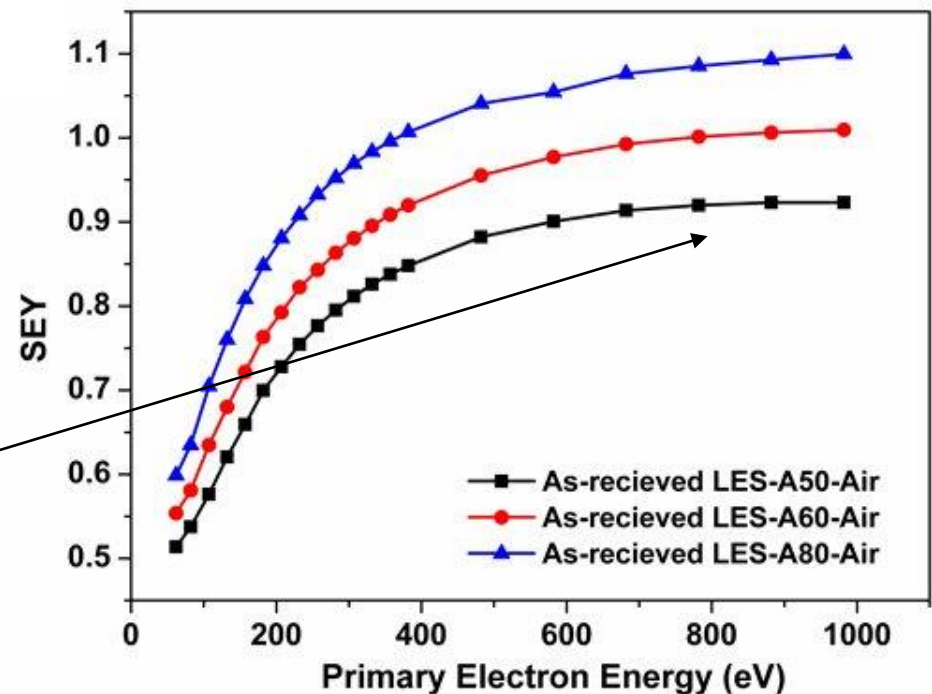
Note  $\delta < 0.85$

Recent Data  
Nov-Dec 2014

Note  $\delta < 0.9$

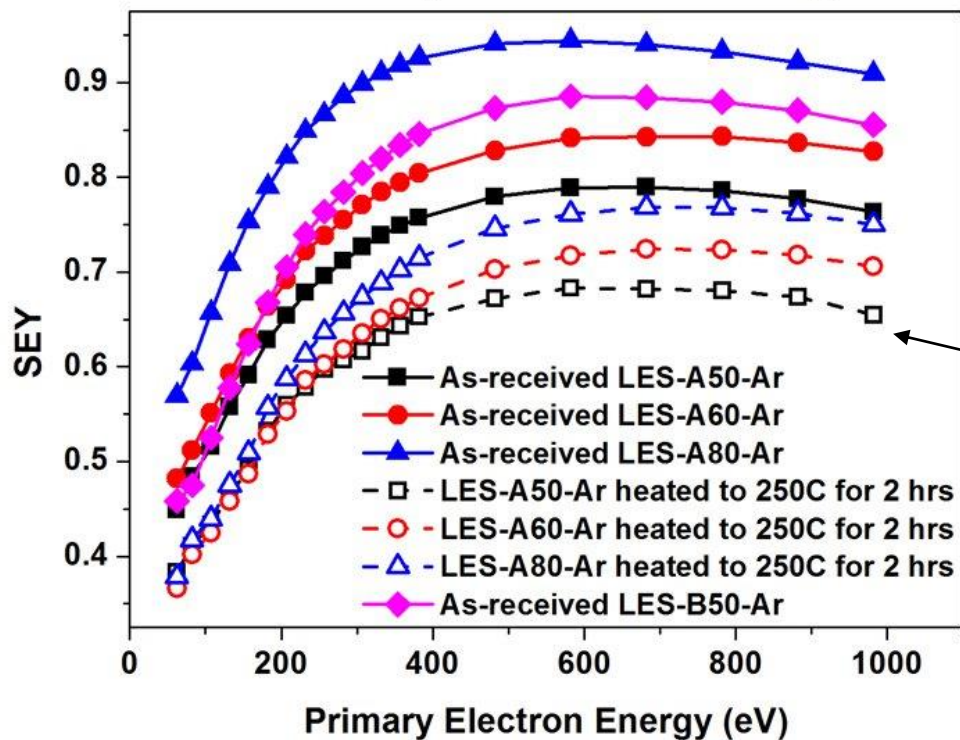
.. and reduces  
to  $< 0.8$

Stainless Steel Laser Engineered Surface in Air





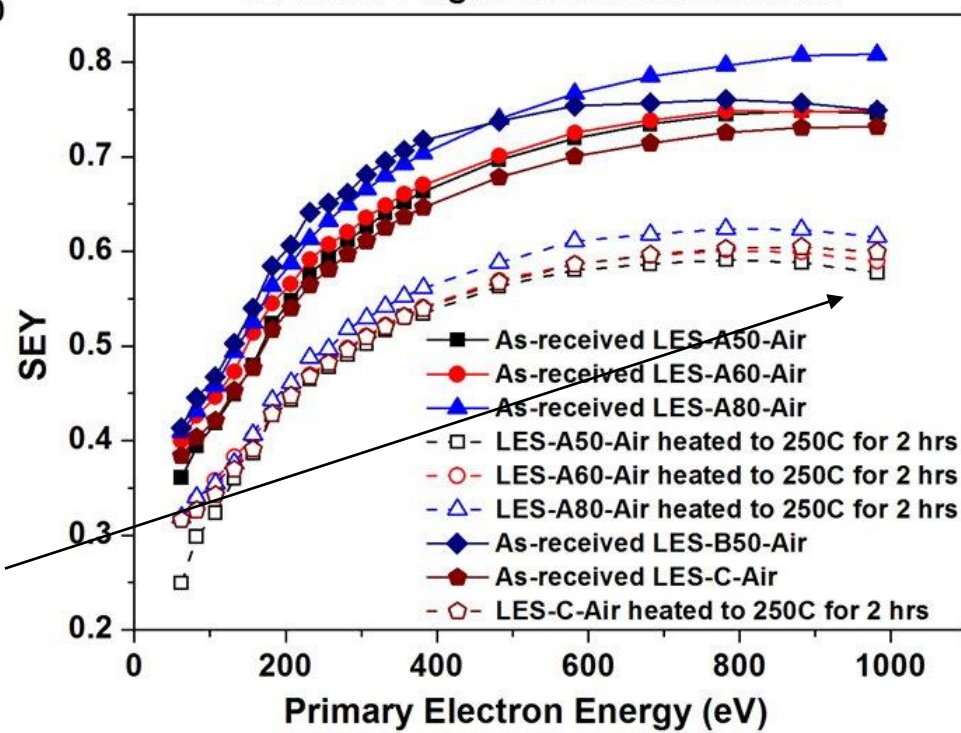
# Cu Laser-Engineered Surfaces in Argon



Copper data

Recent Data  
Nov-Dec 2014

# Cu Laser-Engineered Surfaces in Air

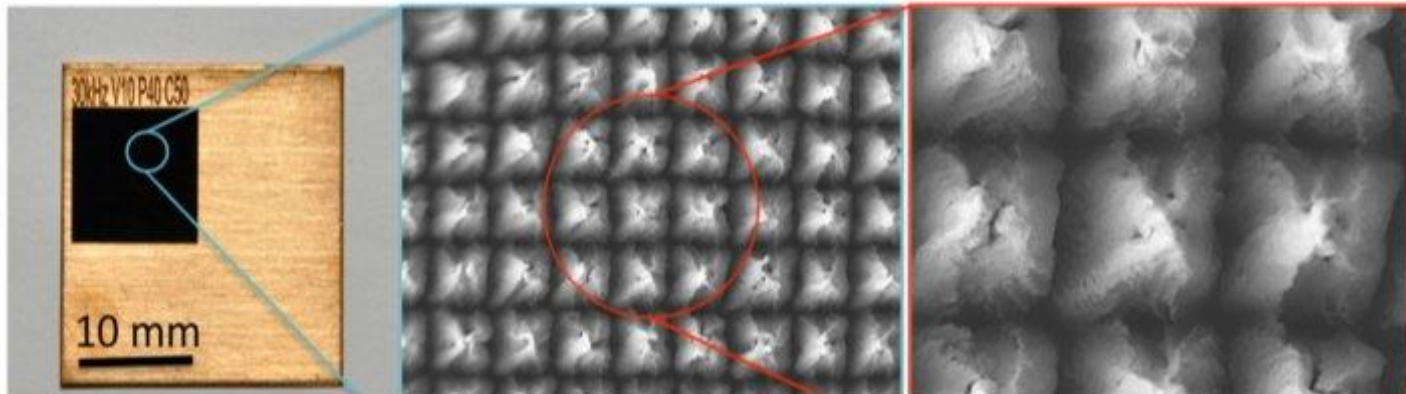


# How do we do this?

## Laser processing of Copper

beam is raster-scanned in both horizontal and vertical directions

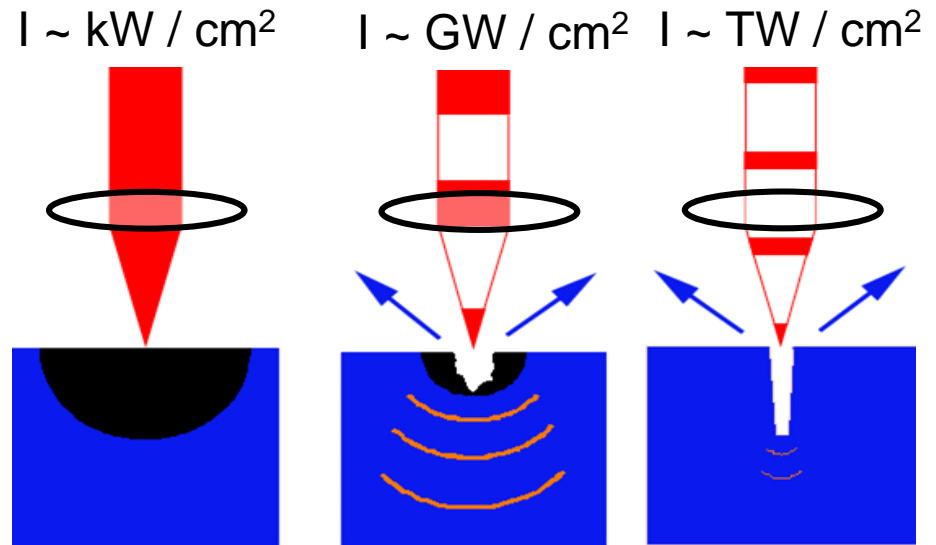
with average laser energy fluence just above ablation threshold of the metal



Appl. Phys. Lett. 101, 2319021 (2012). **Physics Highlights – Physics Today** (February 2013).  
Opt. Mater. Exp. 1,1425 (2011).

# Laser Ablation of Metals - Components of light control

- Laser Wavelength
- Energy & Power
- Spot size & shape of beam
- Pulse length



Part of this **ENERGY** (once randomised) is

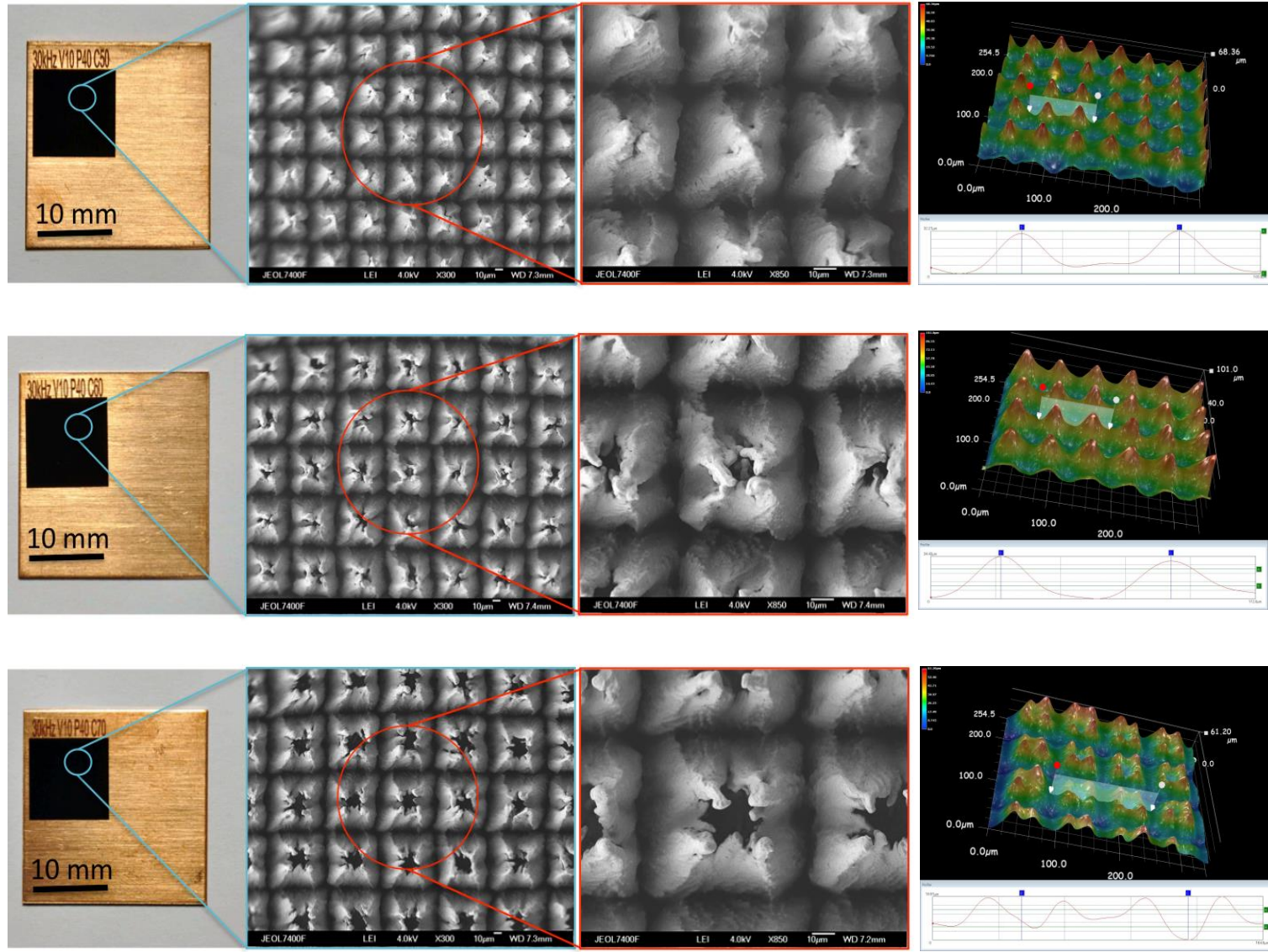
- Conducted into the bulk of the material*
- Converted into directed kinetic energy by thermal expansion of the heated layer.*

**Two separate regimes** are identifiable at high irradiances:

- Short (ns) pulses:** *Dominated by the expansion and ablation of material*
- Ultra-short (ps & fs) pulses:** *Dominated by heat conduction, as hydrodynamic motion during the pulse duration is negligible.*



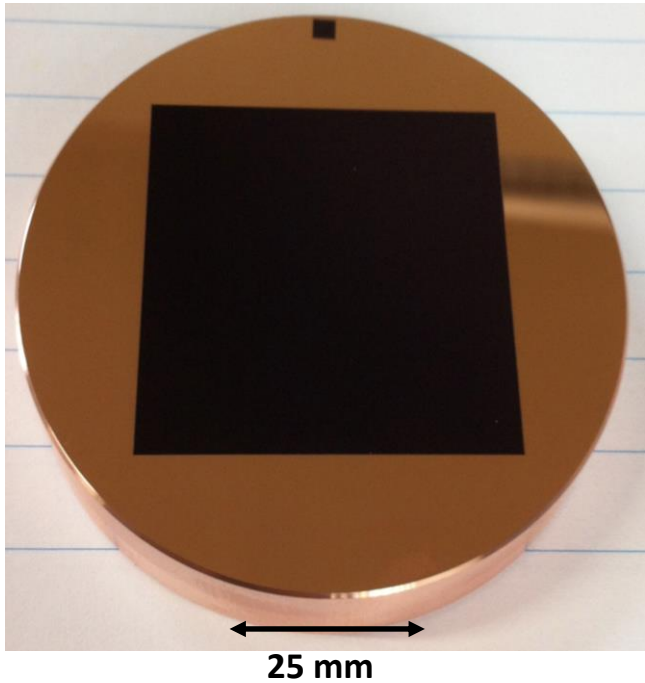
## Material: Copper



Appl. Phys. Lett. 101, 2319021 (2012). **Physics Highlights – Physics Today** (February 2013).  
Opt. Mater. Exp. 1,1425 (2011).



**Metals treated so far**  
Copper; Aluminium; Titanium; S.Steel

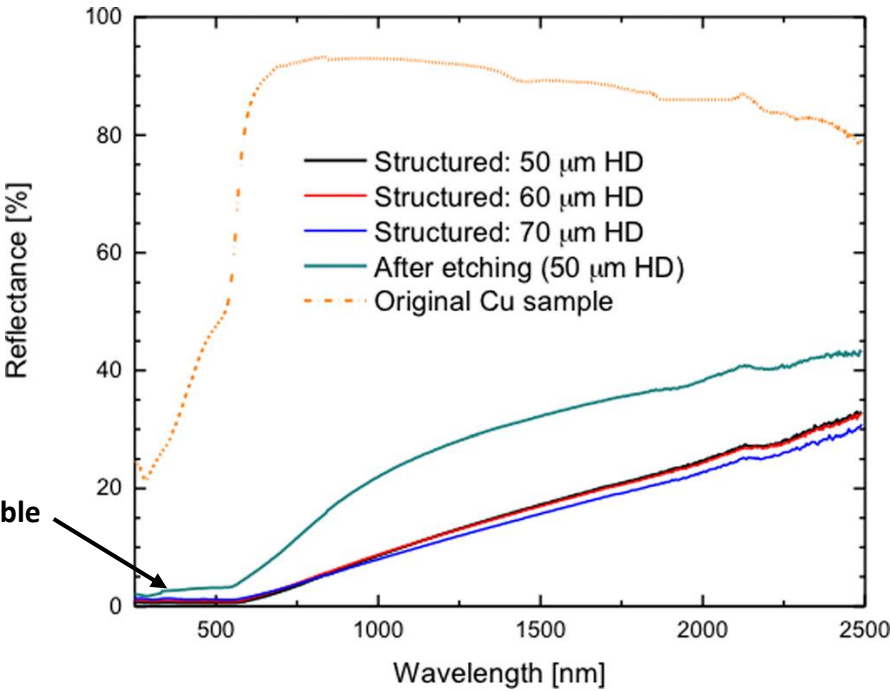


Reflectance of “black copper”

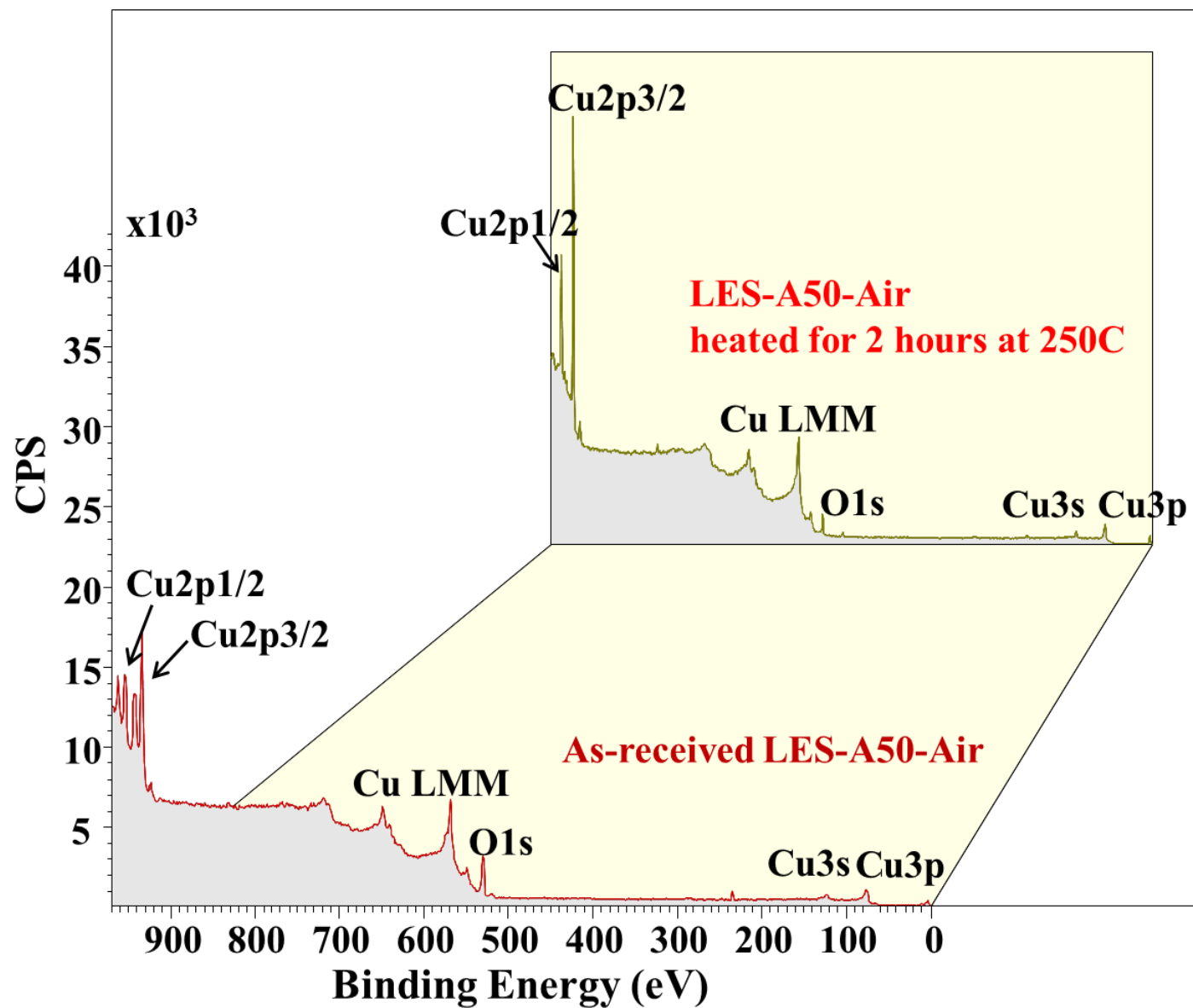
< 3% across visible

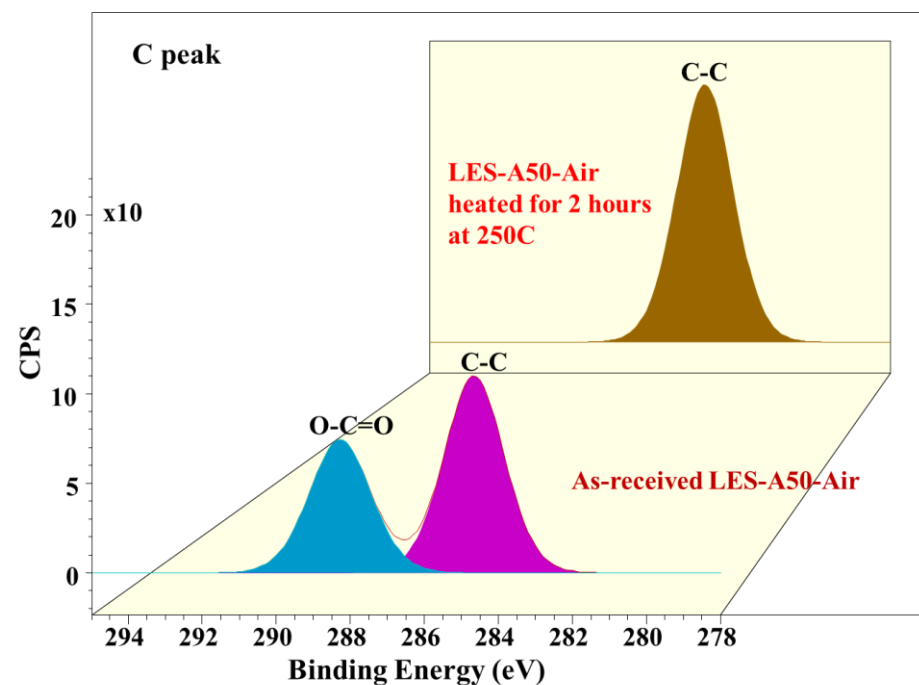
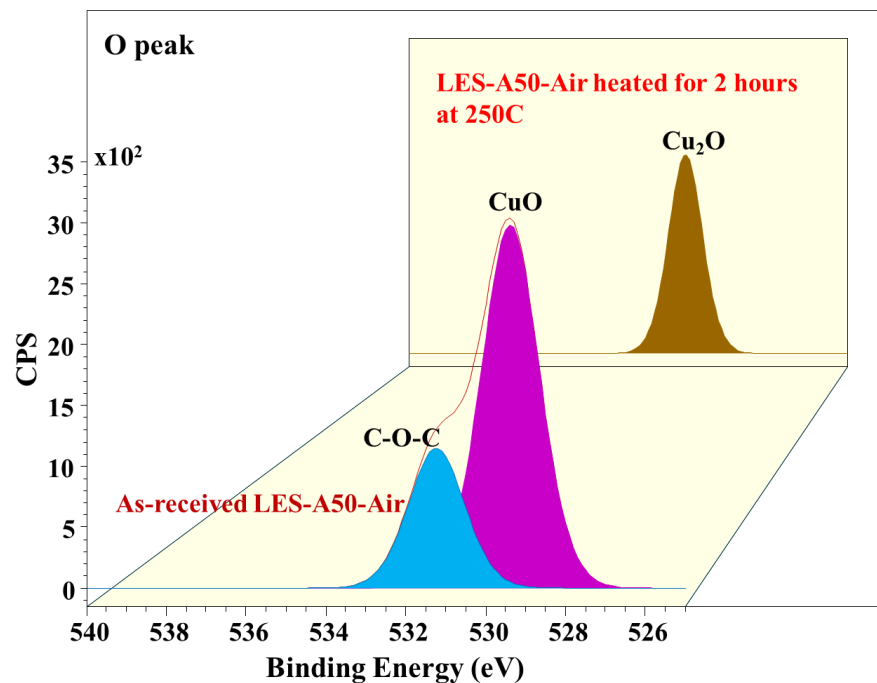
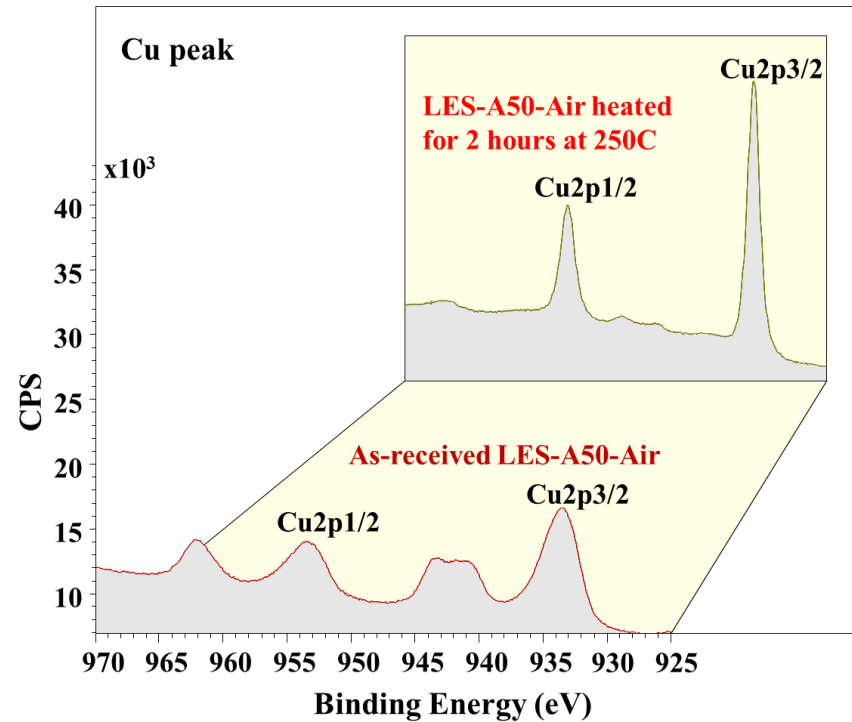
Appl. Phys. Lett. 101, 2319021 (2012).  
Opt. Mater. Exp. 1,1425 (2011).  
Int. J. Adv. Manu. Technol. 66, 1769 (2013).

**A practical example:**  
Laser micro-structured copper mirror ( **an optical / THz separator** )  
Fabricated for the Beam Diagnostics Group at ASTeC, Daresbury Laboratory.



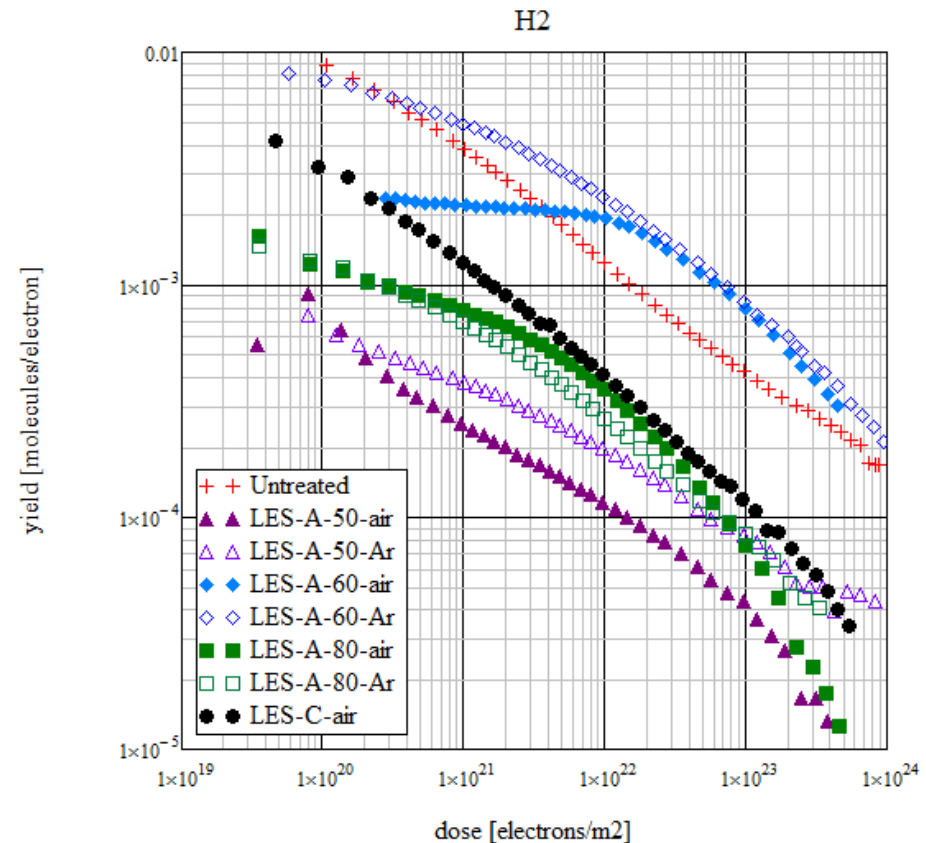
# XPS analysis of Cu sample before & after conditioning





# Electron Stimulated Desorption (ESD)

- 9 samples were tested:
  - Cu blank gaskets  $\varnothing 48$  mm
    - Untreated (2 samples)
    - LES-A type treated in air or Ar atmosphere
    - LES-C type treated in air
  - $E_{e^-} = 500$  eV

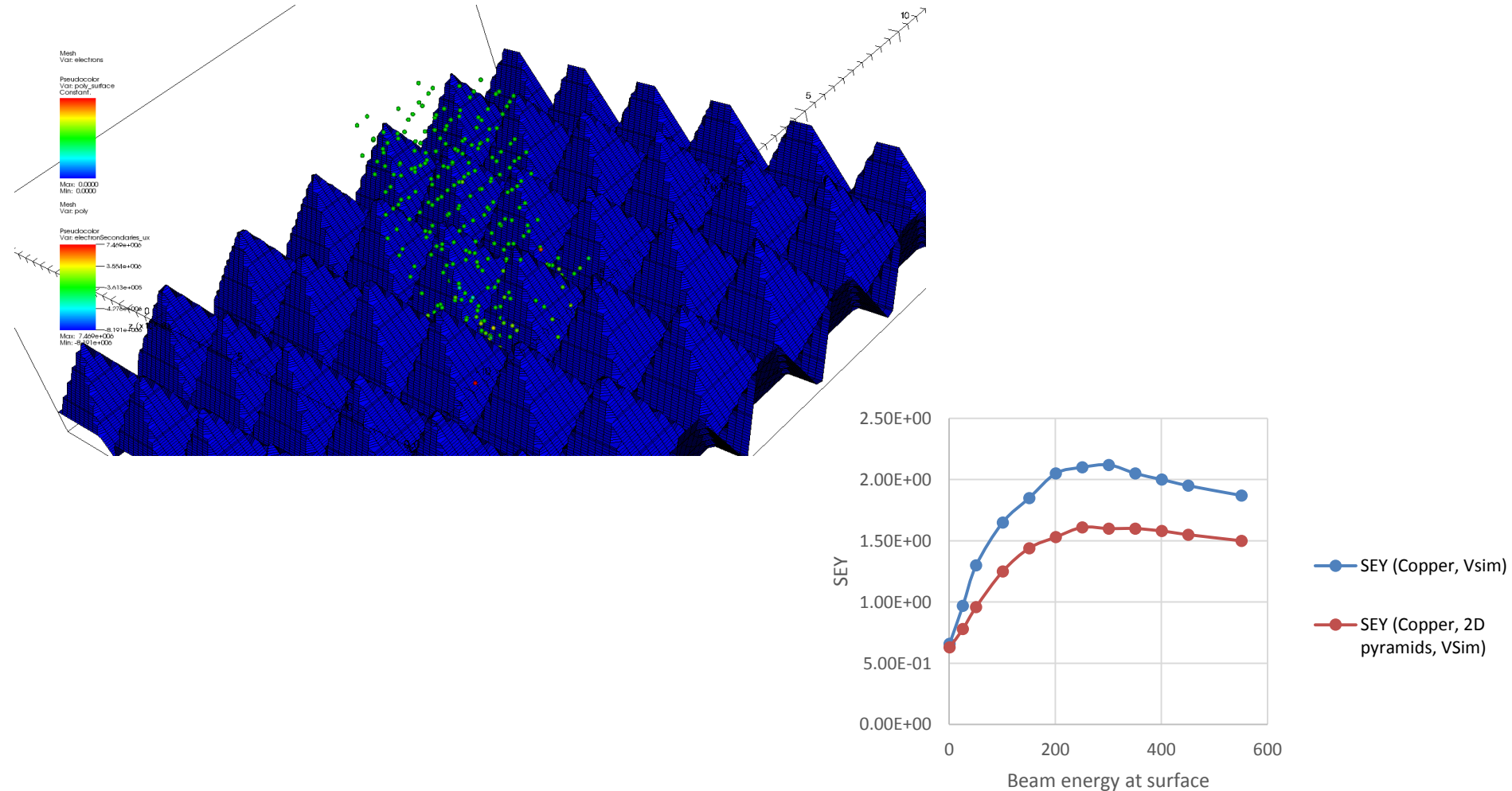


- Main results:
  - LES-A-50, LES-A-50 and LES-C demonstrated lower ESD yields than untreated samples
  - LES-A-50 treated in air yielded the best results



# Simulations

Very preliminary studies of e-cloud mitigation are being carried out  
(using VSim) by Jonathan Smith of Tech-X Corporation in the UK



# Summary

- ❖ Laser conditioning of metal surfaces is a very viable solution for **reducing the SEY  $< 0.6$**
- ❖ **Even the initial (unconditioned) SEY of 1.1 for black SS** is low enough to suppress e-cloud in, e.g., the SPS, LHC or HL-LHC.
- ❖ The technique can easily be applied to existing vacuum surfaces where the improvement has to be done *in-situ* with minimum disturbance to the beam line.
- ❖ The blackening process can be carried out **in air at atmospheric pressure**; the actual cost of the mitigation is therefore considerably lower, a fraction of existing mitigation processes. **The process is also readily scalable to large areas.**
- ❖ The surface is **highly reproducible** and offers a very stable surface chemistry which can be influenced during the process. The surface is robust and is immune to any surface delamination - which can be a detrimental problem for thin-film coatings.
- ❖ The treated surface **remains the same material**, therefore it is unlikely to have a significant effect on the surface impedance – recent measurements verify this.

## nanosecond processing of Al

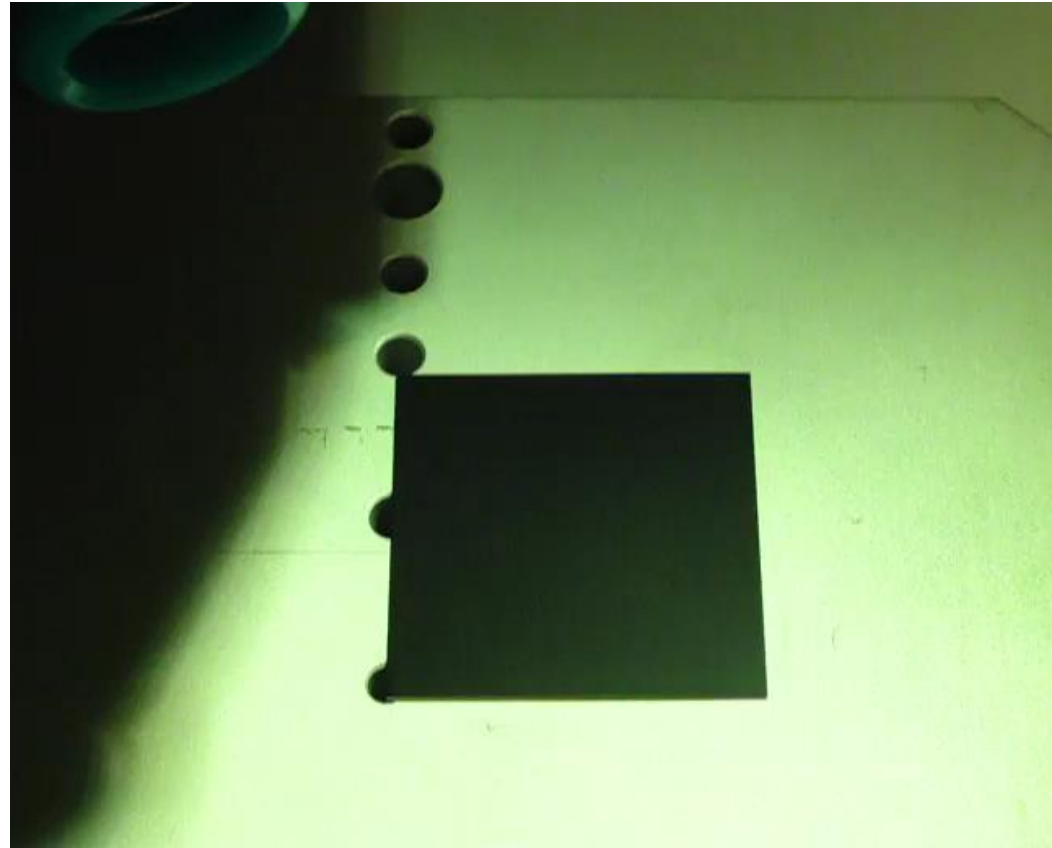
**Material:** Anodised aluminium

**Wavelength:** 1064 nm

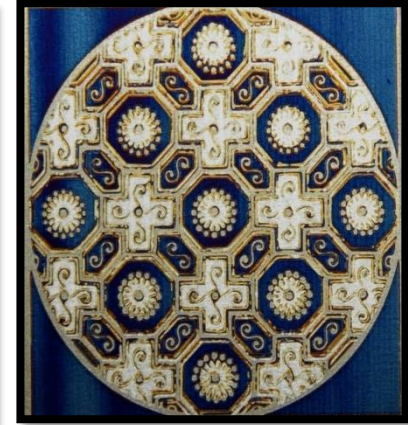
**Pulse length:** 10 ns

**Focal spot diameter:** 60  $\mu\text{m}$

**Processing speed:** 1200 mm/s



# Laser Refractive Index Engineering of Metals



1 cm



## Examples

**Materials:** Titanium & Steel  
**Wavelength:** 1064 nm  
**Pulse length:** < 50 ns  
**Processing speed:** 100 mm/s



*Thank you for your attention*